

MOSFET – Power, N-Channel 100 V, 32 A, 37 mΩ

NTD6414AN, NVD6414AN

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Para	Symbol	Value	Unit		
Drain-to-Source Volta	V _{DSS}	100	V		
Gate-to-Source Volta	ge – Conti	nuous	V _{GS}	±20	V
Continuous Drain	Steady State			32	Α
Current R _{θJC}	State	T _C = 100°C		22	
Power Dissipation $R_{\theta JC}$	Steady State			100	W
Pulsed Drain Current	t _p	= 10 μs	I _{DM}	117	Α
Operating and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body	Diode)		Is	32	Α
Single Pulse Drain-to- Energy (V _{DD} = 50 Vdc I _{L(pk)} = 32 A, L = 0.3 m	E _{AS}	154	mJ		
Lead Temperature for Purposes, 1/8" from C		Seconds	TL	260	°C

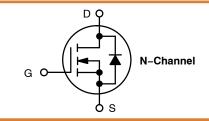
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	37	

Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [1 oz] including traces).

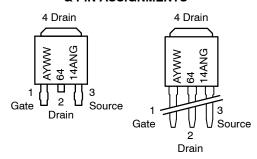
V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)} MAX (No	
100 V	37 mΩ @ 10 V	32 A







MARKING DIAGRAM & PIN ASSIGNMENTS



A = Assembly Location*

Y = Year

WW = Work Week

6414AN = Device Code

G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

NOTE: Some of the devices on this data sheet have been **DISCONTINUED**. Please refer to the table on page 5.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

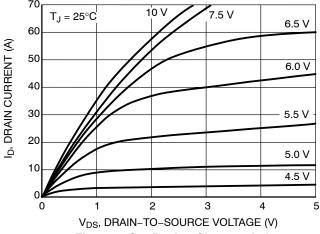
Parameter	Symbol	Test Conditi	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS	-				•	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 2$	250 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				107		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	Vcs = 0 V.	$V_{GS} = 0 \text{ V}.$ $T_J = 25^{\circ}\text{C}$			1.0	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 100 V$	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	•		•		•	•	•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 1$	250 μΑ	2.0		4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				8.3		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 32 A			30	37	mΩ
Forward Transconductance	gFS	V _{GS} = 5.0 V, I _D = 10 A			18		S
CHARGES, CAPACITANCES AND GA	TE RESISTANO	CE	•			•	•
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V			1450		pF
Output Capacitance	C _{OSS}				230		
Reverse Transfer Capacitance	C _{RSS}				95		
Total Gate Charge	Q _{G(TOT)}				40		nC
Threshold Gate Charge	Q _{G(TH)}		•		1.7		
Gate-to-Source Charge	Q_{GS}	V _{GS} = 10 V, V _{DS} = 80	V, I _D = 32 A		8.0		
Gate-to-Drain Charge	Q_{GD}		•		20		
Plateau Voltage	V_{GP}		•		5.9		V
Gate Resistance	R_{G}				1.9		Ω
SWITCHING CHARACTERISTICS (Not	e 4)		-				-
Turn-On Delay Time	t _{d(on)}				11		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DD}	= 80 V,		52		
Turn-Off Delay Time	t _{d(off)}	$I_D = 32 \text{ A}, R_G =$	6.1 Ω΄		38		
Fall Time	t _f	1			48		
DRAIN-SOURCE DIODE CHARACTER	RISTICS					•	•
Forward Diode Voltage	V_{SD}	., .,,,	T _J = 25°C		0.87	1.2	V
		$V_{GS} = 0 \text{ V}, I_S = 32 \text{ A}$	T _J = 125°C		0.76		
Reverse Recovery Time	t _{RR}		•		68		ns
Charge Time	Ta	$V_{GS} = 0 \text{ V, } dI_S/dt =$	100 A/μs.		51		
Discharge Time	T _b	I _S = 32 A			16		1
Reverse Recovery Charge	Q _{RR}		ľ		195		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

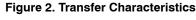
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

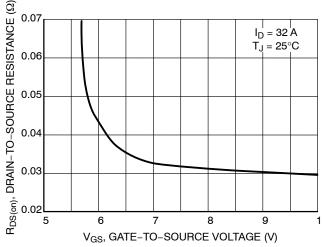
TYPICAL CHARACTERISTICS



70 V_{DS} ≥ 10 V 60 ID, DRAIN CURRENT (A) 50 40 30 20 = 25°C 125°C 10 -55°Ċ 0 2 5 8 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics





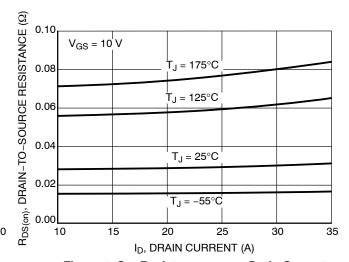
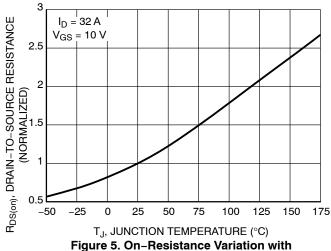


Figure 3. On-Region versus Gate Voltage

Figure 4. On-Resistance versus Drain Current and Gate Voltage



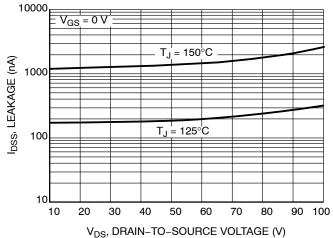
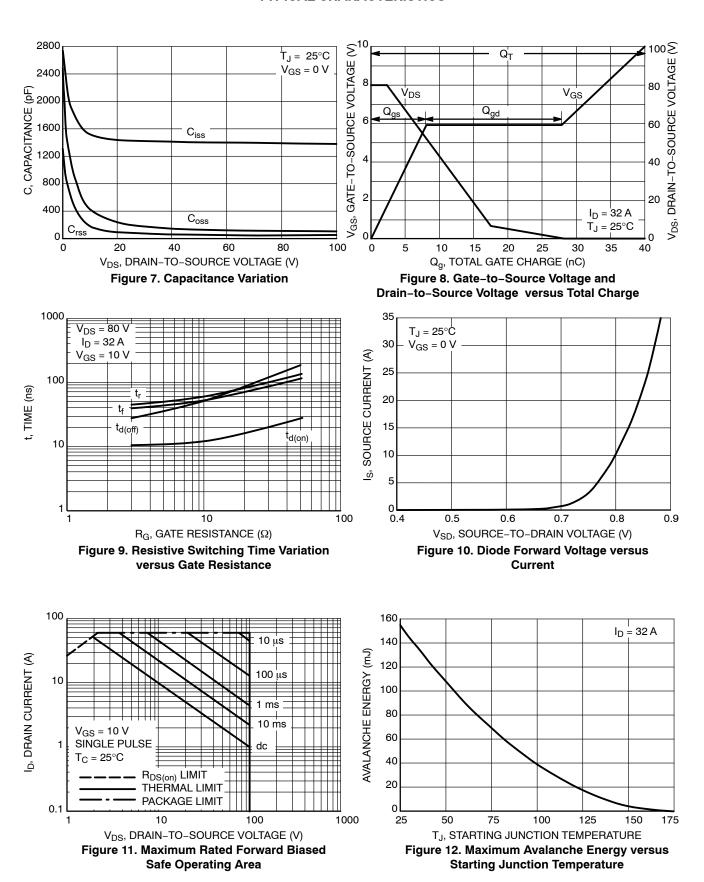


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

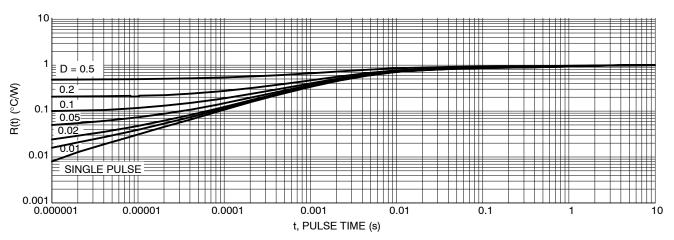


Figure 13. Thermal Response

ORDERING INFORMATION

Device	Package	Shipping†
NTD6414ANT4G	DPAK (Pb-Free)	2500 / Tape & Reel

DISCONTINUED (Note 5)

NTD6414AN-1G	IPAK (Pb-Free)	75 Units / Rail
NVD6414ANT4G*	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{*}NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

^{5.} **DISCONTINUED:** These devices are not recommended for new design. Please contact your **onsemi** representative for information. The most current information on these devices may be available on www.onsemi.com.



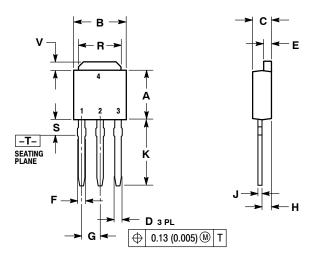


DPAK INSERTION MOUNT

CASE 369 ISSUE O

DATE 02 JAN 2000

SCALE 1:1



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	ETERS
DIM	MIN MAX		MIN	MAX
Α	0.235	0.250	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.033	0.040	0.84	1.01
F	0.037	0.047	0.94	1.19
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.175	0.215	4.45	5.46
S	0.050	0.090	1.27	2.28
٧	0.030	0.050	0.77	1.27

STYLE 1:		STYLE 2:		STYLE 3:		STYLE 4:		STYLE 5:		STYLE 6:	
PIN 1.	BASE	PIN 1.	GATE	PIN 1.	ANODE	PIN 1.	CATHODE	PIN 1.	GATE	PIN 1.	MT1
2.	COLLECTOR	2.	DRAIN	2.	CATHODE	2.	ANODE	2.	ANODE	2.	MT2
3.	EMITTER	3.	SOURCE	3.	ANODE	3.	GATE	3.	CATHODE	3.	GATE
4.	COLLECTOR	4.	DRAIN	4.	CATHODE	4.	ANODE	4.	ANODE	4.	MT2

DOCUMENT NUMBER:	98ASB42319B	Electronic versions are uncontrolled except when accessed directly from the Document Re Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DPAK INSERTION MOUNT		PAGE 1 OF 1	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.



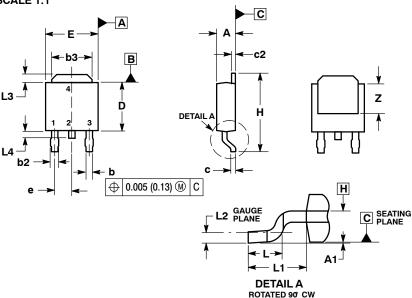
DPAK (SINGLE GUAGE) CASE 369AA **ISSUE B** SCALE 1:1 C

DATE 03 JUN 2010

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER

PIN 1. GATE 2. ANODE 3. CATHODE

4. ANODE

STYLE 5:

4. COLLECTOR

STYLE 2: PIN 1. GATE

STYLE 6:

2. DRAIN 3. SOURCE 4. DRAIN

STYLE 3: PIN 1. ANODE

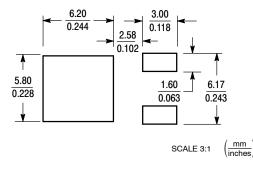
2. CATHODE 3. ANODE CATHODE

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE

STYLE 7:

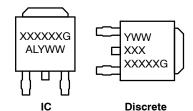
PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER COLLECTOR

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part

DOCUMENT NUMBER:	98AON13126D	Electronic versions are uncontrolled except when accessed directly from the Document Reported versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

onsemi and Onsemi are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries, onsemi reserves the right to make changes without further notice to any products herein. **onsemi** makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales